## SN74ALVC125供应商

## SN74ALVC125 QUADRUPLE BUS BUFFER GATE WITH 3-STATE OUTPUTS

SCES110D - JULY 1997 - REVISED DECEMBER 1998

- EPIC<sup>™</sup> (Enhanced-Performance Implanted **CMOS) Submicron Process**
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- **Package Options Include Plastic** Small-Outline (D), Thin Very Small-Outline (DGV), and Thin Shrink Small-Outline (PW) **Packages**

D, DGV, OR PW PACKAGE (TOP VIEW)								
10E 1A 1Y 20E 2A 2Y GND	2	1 1 1	4 3 1 0 9 8	V <sub>CC</sub>   4OE   4A   4Y   3OE   3A   3Y				

#### description

This quadruple bus buffer gate is designed for 1.65-V to 3.6-V  $V_{CC}$  operation.

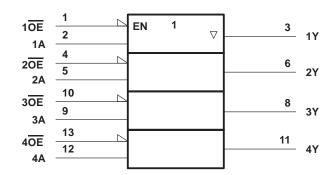
The SN74ALVC125 features independent line drivers with 3-state outputs. Each output is disabled when the associated output-enable ( $\overline{OE}$ ) input is high.

To ensure the high-impedance state during power up or power down,  $\overline{\text{OE}}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74ALVC125 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each buffer)							
INPUTS OUTPUT							
OE	Α	Y					
L	Н	Н					
L	L	L					
Н	Х	Z					

## logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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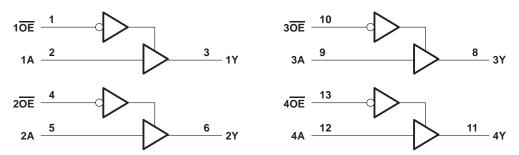
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## logic diagram (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)		
Output voltage range, $V_O$ (see Note 1)		
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)		
Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0)		
Continuous output current, I <sub>O</sub>		±50 mA
Continuous current through V <sub>CC</sub> or GND		±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3)		
	DGV package	
	PW package	170°C/W
Storage temperature range, T <sub>stg</sub>		

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed. 2. This value is limited to 4.6 V maximum.

3. The package thermal impedance is calculated in accordance with JESD 51.



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## recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
VCC	Supply voltage		1.65	3.6	V
		V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65 \times V_{CC}$		
VIH	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		
		V <sub>CC</sub> = 1.65 V to 1.95 V		$0.35 \times V_{CC}$	
VIL	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V
		V <sub>CC</sub> = 2.7 V to 3.6 V		0.8	
VI	Input voltage		0	VCC	V
VO	Output voltage		0	VCC	V
		V <sub>CC</sub> = 1.65 V		-4	
lau	High-level output current	V <sub>CC</sub> = 2.3 V		-12	mA
ЮН		$V_{CC} = 2.7 V$		-12	
		V <sub>CC</sub> = 3 V		-24	
		V <sub>CC</sub> = 1.65 V		4	
la.	Low-level output current	$V_{CC} = 2.3 V$		12	4
IOL		V <sub>CC</sub> = 2.7 V		12	mA
		V <sub>CC</sub> = 3 V		24	
Тд	Operating free-air temperature		-40	85	°C

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics	over	recommended	operating	free-air	temperature	range	(unless
otherwise noted)					-	•	

PA	RAMETER	TEST CONDITIONS	Vcc	MIN	түр†	MAX	UNIT		
		I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V	V <sub>CC</sub> -0.2	2				
		$I_{OH} = -4 \text{ mA}$	1.65 V	1.2					
		$I_{OH} = -6 \text{ mA}$	2.3 V	2					
Vон			2.3 V	1.7			V		
		$I_{OH} = -12 \text{ mA}$	2.7 V	2.2					
			3 V	2.4					
		$I_{OH} = -24 \text{ mA}$	3 V	2					
	I <sub>OL</sub> = 100 μA	1.65 V to 3.6 V			0.2				
Max		I <sub>OL</sub> = 4 mA	1.65 V					0.45	
		I <sub>OL</sub> = 6 mA	2.3 V			0.4	v		
VOL	10 m 10 m 1	2.3 V			0.7				
		I <sub>OL</sub> = 12 mA	2.7 V			0.4			
		I <sub>OL</sub> = 24 mA	3 V			0.55			
Ц		$V_{I} = V_{CC} \text{ or } GND$	3.6 V			±5	μΑ		
IOZ		$V_{O} = V_{CC}$ or GND	3.6 V			±10	μΑ		
ICC		$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	3.6 V			10	μA		
∆ICC		One input at $V_{CC}$ – 0.6 V, Other inputs at $V_{CC}$ or GND	3 V to 3.6 V			750	μA		
0.	Control inputs		0.01/	3.5			- F		
Ci	Data inputs	VI = V <sub>CC</sub> or GND	3.3 V		3.5		рF		
Co	Outputs	$V_{O} = V_{CC}$ or GND	3.3 V		5.5		pF		

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> =  $25^{\circ}$ C.

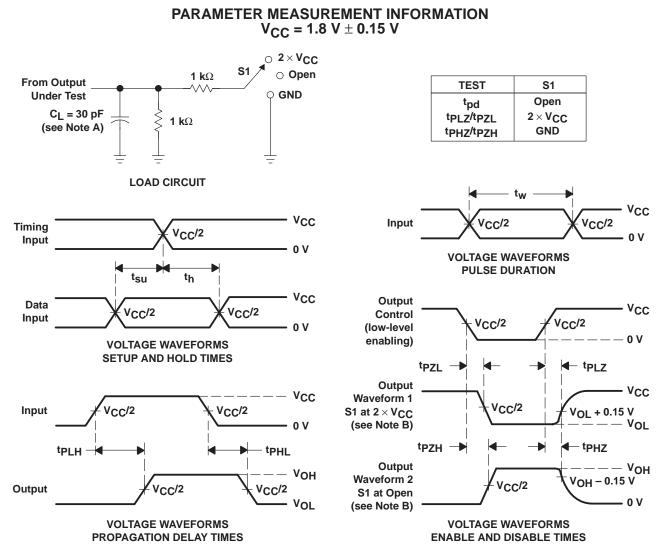
# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = ± 0.1		V <sub>CC</sub> = ± 0.2	2.5 V 2 V	V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = ± 0.3	3.3 V 3 V	UNIT
		(001-01)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> pd	A	Y	1.3	5.3	1	3.2		3.1	1.1	2.8	ns
t <sub>en</sub>	OE	Y	1.4	6.4	1	4.1		4.3	1	3.5	ns
<sup>t</sup> dis	OE	Y	1.8	5.9	1	3.4		4	1.4	4	ns

## operating characteristics, $T_A = 25^{\circ}C$

PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT	
Power dissipation		Outputs enabled	C <sub>L</sub> = 0,	15	17	19	<b>"</b> Г
C <sub>pd</sub> capacitance per gate	Outputs disabled	f = 10  MHz	2	2	3	рF	





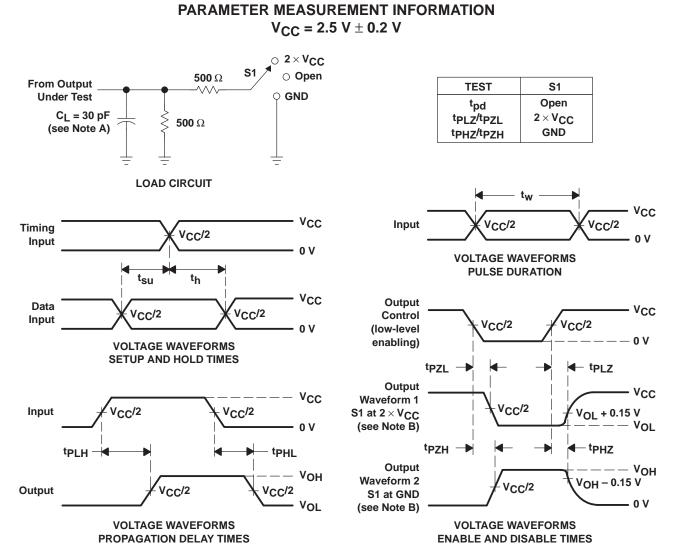
- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.
  - D. The outputs are measured one at a time with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

#### Figure 1. Load Circuit and Voltage Waveforms



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- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C.
  - All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.
  - D. The outputs are measured one at a time with one transition per measurement.
  - E. tPLZ and tPHZ are the same as tdis.
  - F. tp7I and tp7H are the same as ten.
  - G. tpi H and tpHi are the same as tpd.

#### Figure 2. Load Circuit and Voltage Waveforms



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PARAMETER MEASUREMENT INFORMATION  $V_{CC}$  = 2.7 V AND 3.3 V ± 0.3 V 6 V  $\cap$ TEST **S1 S1 500** Ω Open  $\cap$ tpd Open From Output  $\langle \Lambda \Lambda \rangle$ 6 V tPLZ/tPZL Under Test С GND GND tPHZ/tPZH  $C_L = 50 \text{ pF}$ **500** Ω (see Note A) LOAD CIRCUIT tw 2.7 V Input 1.5 V 1.5 V 2.7 V Timing 0 V 1.5 V Input 0 V **VOLTAGE WAVEFORMS** PULSE DURATION t<sub>su</sub> th 2.7 V Data 1.5 V 1.5 V 2.7 V Output Input 0 V Control 1.5 V 1.5 V (low-level **VOLTAGE WAVEFORMS** enabling) 0 V SETUP AND HOLD TIMES <sup>t</sup>PZL **t**PLZ 3 V Output 2.7 V Waveform 1 1.5 V Input 1.5 V 1.5 V V<sub>OL</sub> + 0.3 V S1 at 6 V VOL 0 V (see Note B) tPHZ -<sup>t</sup>PLH tPZH -<sup>t</sup>PHL Output ۷он Waveform 2 V<sub>OH</sub> – 0.3 V VOH 1.5 V S1 at GND Output 1.5 V 1.5 V (see Note B) 0 V VOL **VOLTAGE WAVEFORMS VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES** ENABLE AND DISABLE TIMES

- NOTES: A.  $C_{\mbox{L}}$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
  - D. The outputs are measured one at a time with one transition per measurement.
  - E. tpLZ and tpHZ are the same as tdis.
  - F. tpzL and tpzH are the same as ten.
  - G. tPLH and tPHL are the same as tpd.

#### Figure 3. Load Circuit and Voltage Waveforms



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